

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10722155	SANA ET AL.
Examiner	Art Unit	
Young J Kim	1637	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
patent databases (USPT, USPPGP, EPO, JPO, DERWENT, IBM-TDB)	3/7/2008	YJK
see enclosed for text-search strategy	3/7/2008	YJK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner